

Notice of References Cited

Application/Control No.
09/911,033

Applicant(s)/Patent Under
Reexamination
LACKRITZ ET AL.

Examiner
Kaj Olsen

Art Unit
1753

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	N	WO 98/27423	06-1998	WIPO	Buchmeiser et al.	
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NON-PATENT DOCUMENTS

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	U	Kameoka et al, Analytical Chemistry, 73(9), pp. 1935-1941, 2001.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.